

Notice of References Cited	Application/Control No. 10/670,269	Applicant(s)/Patent Under Reexamination HSIEH, YOU-JUN	
	Examiner Jean E. Lesperance	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,525,743 B1	02-2003	Patrick et al.	345/619
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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